DATA SHEET

BF1105; BF1105R; BF1105WR
N-channel dual-gate MOS-FETs

Product specification
Supersedes data of 1997 Dec 01

1997 Dec 02

N-channel dual-gate MOS-FETs

BF1105; BF1105R; BF1105WR

FEATURES

- Short channel transistor with high forward transfer admittance to input capacitance ratio
- Low noise gain controlled amplifier up to 1 GHz.
- Internal self-biasing circuit to ensure good cross-modulation performance during AGC and good DC stabilization.

APPLICATIONS

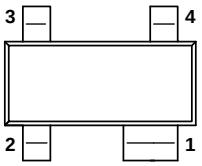
- VHF and UHF applications with 5 V supply voltage, such as television tuners and professional communications equipment.

DESCRIPTION

Enhancement type N-channel field-effect transistor with source and substrate interconnected. Integrated diodes between gates and source protect against excessive input voltage surges. The BF1105, BF1105R and BF1105WR are encapsulated in the SOT143B, SOT143R and SOT343R plastic packages respectively.

PINNING

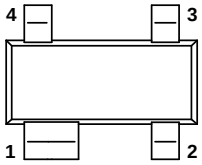
PIN	DESCRIPTION
1	source
2	drain
3	gate 2
4	gate 1



Top view MSB035

BF1105R marking code: NAp.

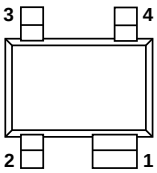
Fig.2 Simplified outline (SOT143R).



Top view MSB014

BF1105 marking code: NEp.

Fig.1 Simplified outline (SOT143B).



Top view MSB842

BF1105WR marking code: NA.

Fig.3 Simplified outline (SOT343R).

QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V_{DS}	drain-source voltage		–	–	7	V
I_D	drain current		–	–	30	mA
P_{tot}	total power dissipation	$T_{amb} \leq 80$ °C	–	–	200	mW
$\lvert y_{fs} \rvert$	forward transfer admittance		25	31	–	mS
$C_{ig1\text{-}ss}$	input capacitance at gate 1		–	2.2	2.7	pF
C_{rss}	reverse transfer capacitance	f = 1 MHz	–	25	40	fF
F	noise figure	f = 800 MHz	–	1.7	2.5	dB
X_{mod}	cross-modulation	input level for k = 1% at 40 dB AGC	100	–	–	dBμV
T_j	operating junction temperature		–	–	150	°C

CAUTION

This product is supplied in anti-static packing to prevent damage caused by electrostatic discharge during transport and handling.

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V_{DS}	drain-source voltage		–	7	V
I_D	drain current		–	30	mA
I_{G1}	gate 1 current		–	±10	mA
I_{G2}	gate 2 current		–	±10	mA
P_{tot}	total power dissipation	$T_{amb} \leq 80$ °C; note 1; see Fig.4	–	200	mW
T_{stg}	storage temperature		−65	+150	°C
T_j	operating junction temperature		–	+150	°C

Note

1. Device mounted on a printed-circuit board.

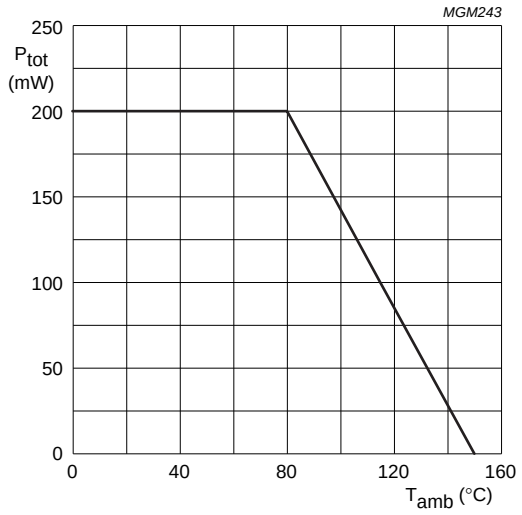


Fig.4 Power derating curve.

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
$R_{th\ j\text{-}a}$	thermal resistance from junction to ambient in free air	note 1	350	K/W
$R_{th\ j\text{-}s}$	thermal resistance from junction to soldering point		200	K/W

Note

1. Device mounted on a printed-circuit board.

STATIC CHARACTERISTICS

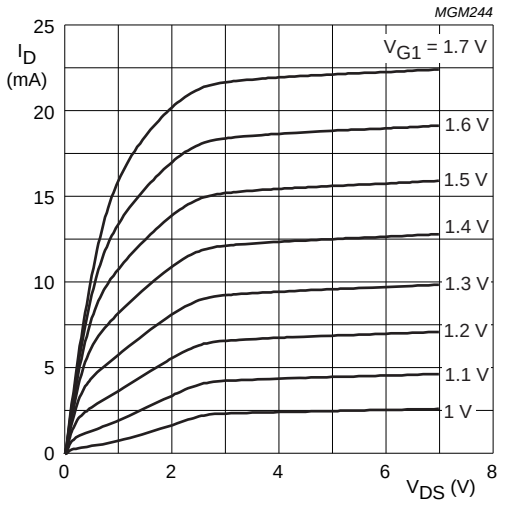
T_j = 25 °C unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_{(BR)DSS}$	drain-source breakdown voltage	$V_{G1\text{-}S} = V_{G2\text{-}S} = 0$; I_D = 10 μA	7	–	–	V
$V_{(BR)G1\text{-}SS}$	gate 1-source breakdown voltage	$V_{G2\text{-}S} = 0$; $I_D = 0$; $I_{G1\text{-}S}$ = 10 μA	7	–	–	V
$V_{(BR)G2\text{-}SS}$	gate 2-source breakdown voltage	$V_{G1\text{-}S} = V_{DS} = 0$; $I_{G2\text{-}S}$ = 10 μA	7	–	–	V
$V_{G2\text{-}S\ (th)}$	gate 2-source threshold voltage	$V_{G1\text{-}S}$ = 5 V; V_{DS} = 5 V; I_D = 20 μA	0.3	0.8	1.2	V
I_{DSX}	self-biasing drain current	$V_{G2\text{-}S}$ = 4 V; V_{DS} = 5 V	8	–	16	mA
$I_{G1\text{-}SS}$	gate 1 cut-off current	$V_{G1\text{-}S}$ = 5 V; $V_{G2\text{-}S} = 0$; $I_D = 0$	–	–	50	nA
$I_{G2\text{-}SS}$	gate 2 cut-off current	$V_{G1\text{-}S} = V_{DS} = 0$; $V_{G2\text{-}S}$ = 4 V	–	–	20	nA

DYNAMIC CHARACTERISTICS

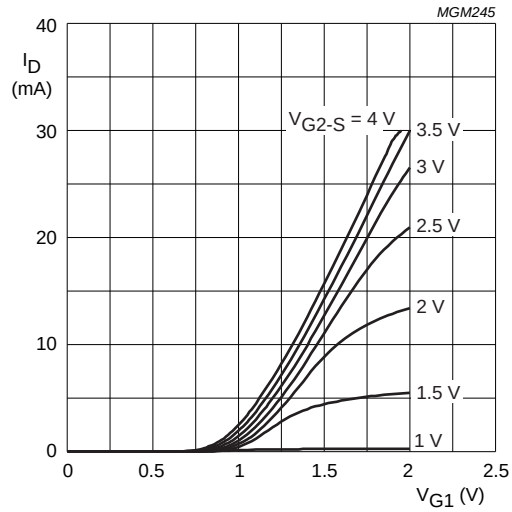
Common source; T_{amb} = 25 °C; $V_{G2\text{-}S}$ = 4 V; V_{DS} = 5 V; self-biasing current; unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$\lvert y_{fs} \rvert$	forward transfer admittance	pulsed; T_j = 25 °C	25	31	–	mS
$C_{ig1\text{-}ss}$	input capacitance at gate 1	f = 1 MHz	–	2.2	2.7	pF
$C_{ig2\text{-}ss}$	input capacitance at gate 2	f = 1 MHz	–	1.6	–	pF
C_{oss}	output capacitance	f = 1 MHz	–	1.2	–	pF
C_{rss}	reverse transfer capacitance	f = 1 MHz	–	25	40	fF
F	noise figure	f = 800 MHz; $Y_S = Y_{S\ opt}$	–	1.7	2.5	dB
G_p	power gain	G_S = 2 mS; $B_S = B_{S\ opt}$; G_L = 0.5 mS; $B_L = B_{L\ opt}$; f = 200 MHz; see Fig.16	–	38	–	dB
		G_S = 3.3 mS; $B_S = B_{S\ opt}$; G_L = 1 mS; $B_L = B_{L\ opt}$; f = 800 MHz; see Fig.17	–	20	–	dB
X_{mod}	cross-modulation	input level for k = 1% at 0 dB AGC; f_w = 50 MHz; f_{unw} = 60 MHz; see Fig.18	85	–	–	dBμV
		input level for k = 1% at 40 dB AGC; f_w = 50 MHz; f_{unw} = 60 MHz; see Fig.18	100	–	–	dBμV



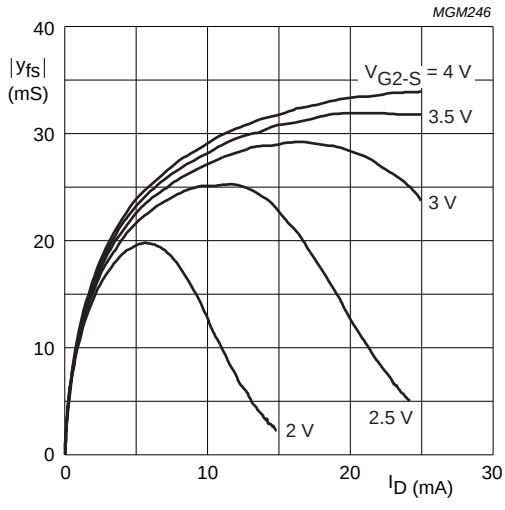
$V_{G2\text{-}S}$ = 4 V.
T_j = 25 °C.

Fig.5 Output characteristics; typical values.



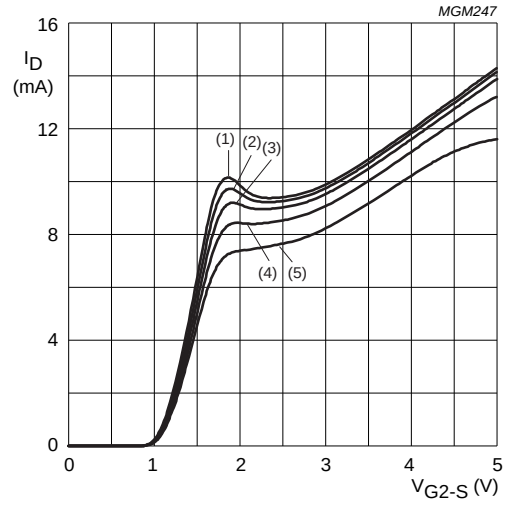
V_{DS} = 5 V.
T_j = 25 °C.

Fig.6 Transfer characteristics; typical values.



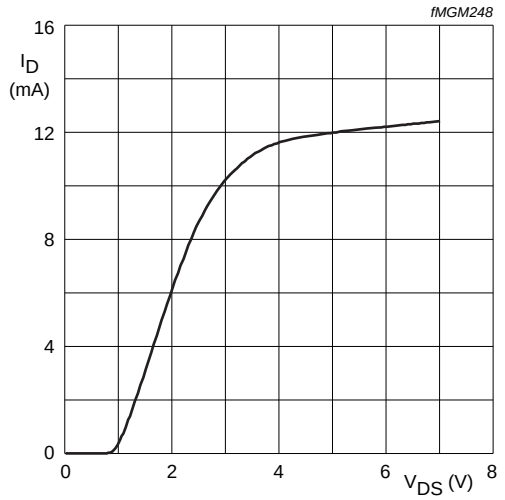
V_{DS} = 5 V.
T_j = 25 °C.

Fig.7 Forward transfer admittance as a function of drain current; typical values.



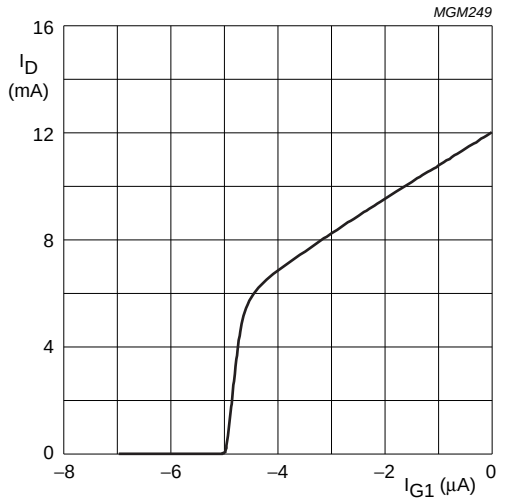
(1) V_{DS} = 5 V.
(2) V_{DS} = 4.5 V.
(3) V_{DS} = 4 V.
(4) V_{DS} = 3.5 V.
(5) V_{DS} = 3 V.

Fig.8 Drain current as a function of gate 2 voltage; typical values.



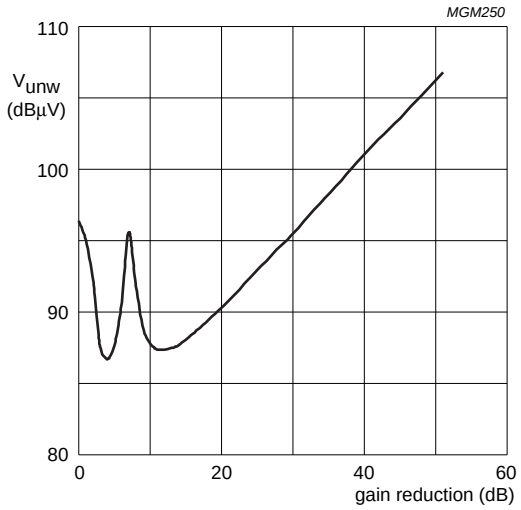
$V_{G2\text{-}S}$ = 4 V.
T_j = 25 °C.

Fig.9 Drain current as a function of drain-source voltage; typical values.



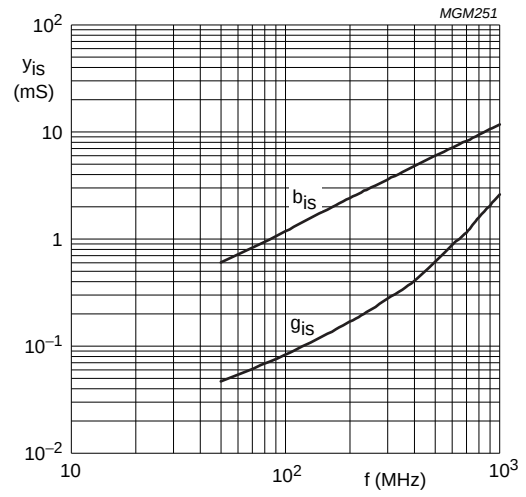
V_{DS} = 5 V; $V_{G2\text{-}S}$ = 4 V; T_j = 25 °C.

Fig.10 Drain current as a function of gate 1 current; typical values.



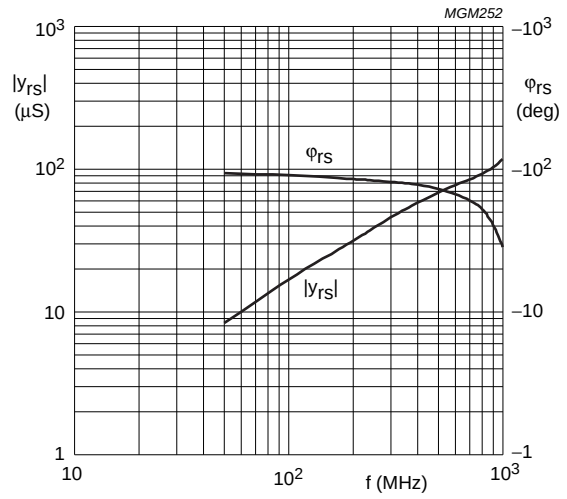
V_{DS} = 5 V; V_{G2nom} = 4 V; $I_{Dnom} = I_{self\ bias}$; f_w = 50 MHz; f_{unw} = 60 MHz; T_{amb} = 25 °C.

Fig.11 Unwanted voltage for 1% cross-modulation as a function of gain reduction; typical values (see Fig.18).



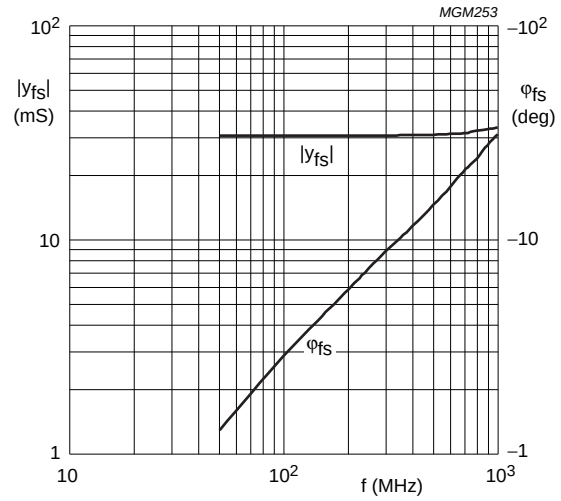
V_{DS} = 5 V; V_{G2-S} = 4 V.
I_D = 12 mA; T_{amb} = 25 °C.

Fig.12 Input admittance as a function of frequency; typical values.



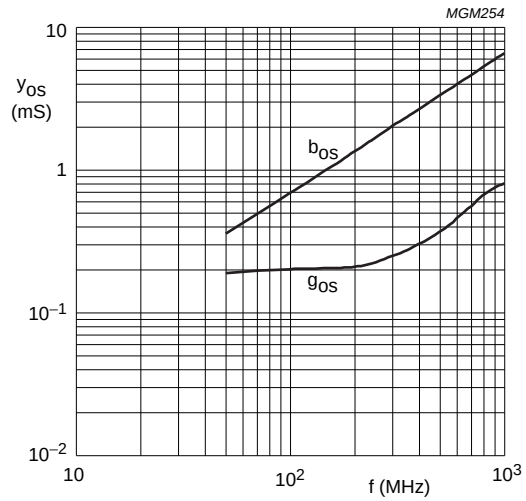
V_{DS} = 5 V; V_{G2-S} = 4 V.
I_D = 12 mA; T_{amb} = 25 °C.

Fig.13 Reverse transfer admittance and phase as a function of frequency; typical values.



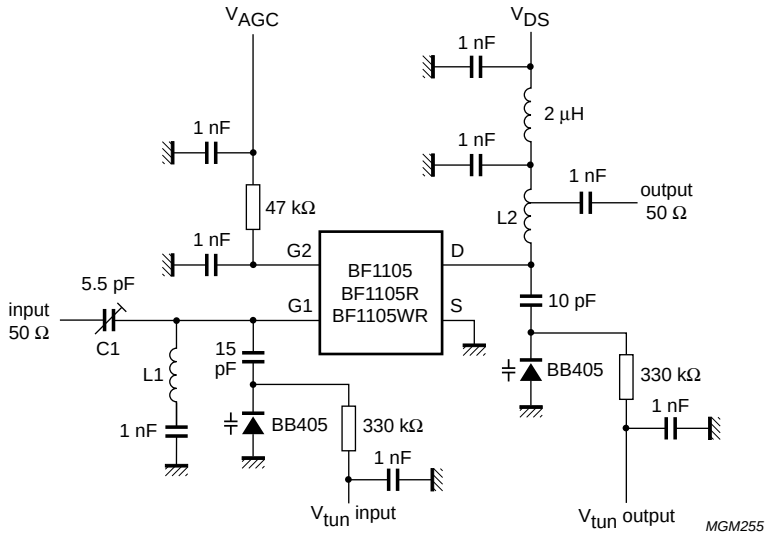
V_{DS} = 5 V; V_{G2-S} = 4 V.
I_D = 12 mA; T_{amb} = 25 °C.

Fig.14 Forward transfer admittance and phase as a function of frequency; typical values.



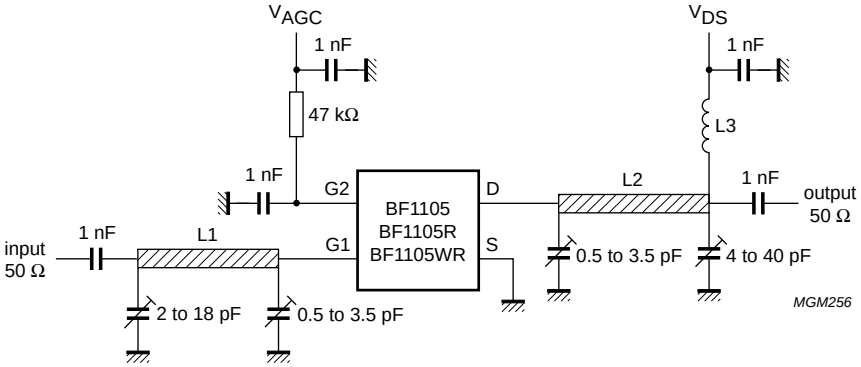
V_{DS} = 5 V; V_{G2-S} = 4 V.
I_D = 12 mA; T_{amb} = 25 °C.

Fig.15 Output admittance as a function of frequency; typical values.



V_{DS} = 5 V, G_S= 2 mS, G_L = 0.5 mS, f = 200 MHz.
L1 = 45 nH, 4 turns, internal diameter = 4 mm, 0.8 mm copper wire.
L2 = 160 nH, 3 turns, internal diameter = 8 mm, 0.8 mm copper wire; tapped at approximately half a turn from the cold side, to set G_L = 0.5 mS.
C1 adjusted for G_S = 2 mS.

Fig.16 Gain test circuit.



V_{DS} = 5 V, G_S= 3.3 mS, G_L = 1 mS, f = 800 MHz.
L1 = 2 cm, silvered 0.8 mm copper wire 4 mm above ground plane.
L2 = 2 cm, silvered 0.8 mm copper wire 4 mm above ground plane.
L3 = 11 turns 0.5 mm copper wire without spacing, internal diameter = 3 mm, L = approx. 200 nH.

Fig.17 Gain test circuit.

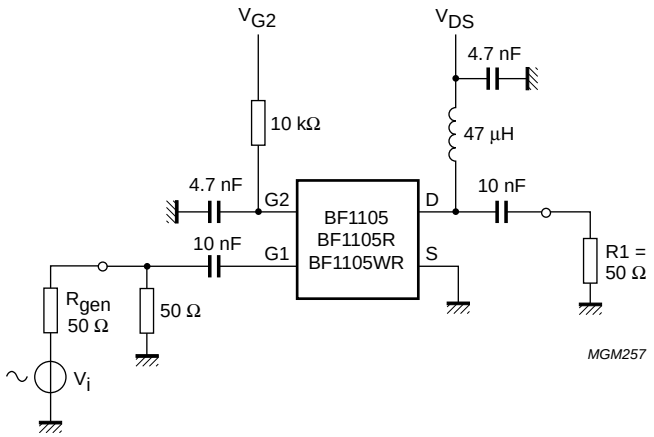


Fig.18 Cross-modulation test set-up.

Table 1 Scattering parameters: V_{DS} = 5 V; $V_{G2\text{-}S}$ = 4 V; I_D = 12 mA

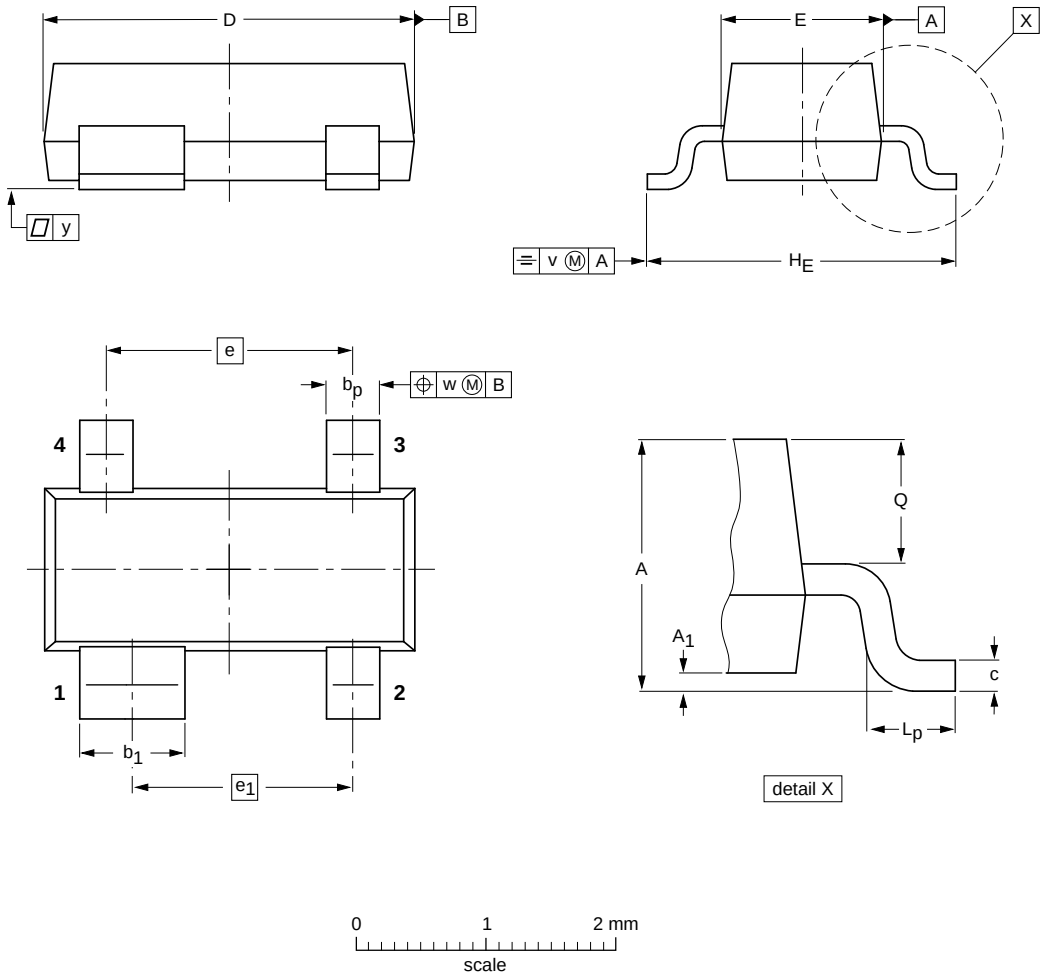
f (MHz)	S_{11}		S_{21}		S_{12}		S_{22}	
	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)
50	0.994	−3.8	3.060	175.4	0.000	86.9	0.985	−2.1
100	0.991	−7.5	3.047	170.9	0.002	86.1	0.983	−4.2
200	0.982	−14.7	3.004	162.1	0.003	82.7	0.980	−8.3
300	0.968	−21.7	2.932	153.4	0.004	79.7	0.976	−12.1
400	0.956	−28.8	2.896	145.3	0.006	77.8	0.972	−16.2
500	0.937	−35.4	2.815	137.1	0.007	76.7	0.967	−20.0
600	0.918	−41.8	2.735	129.2	0.007	76.3	0.961	−23.7
700	0.897	−48.1	2.651	121.5	0.008	76.7	0.955	−27.3
800	0.878	−54.0	2.575	114.0	0.008	79.7	0.948	−30.9
900	0.858	−59.9	2.482	106.5	0.008	82.2	0.941	−34.4
1000	0.840	−65.5	2.396	99.5	0.008	88.0	0.935	−37.9

Table 2 Noise data: V_{DS} = 5 V; $V_{G2\text{-}S}$ = 4 V; I_D = 12 mA

f (MHz)	F_{min} (dB)	Γ_{opt}		R_n (Ω)
		(ratio)	(deg)	
800	1.5	0.674	39.7	37.15

PACKAGE OUTLINES

Plastic surface-mounted package; 4 leads **SOT143B**

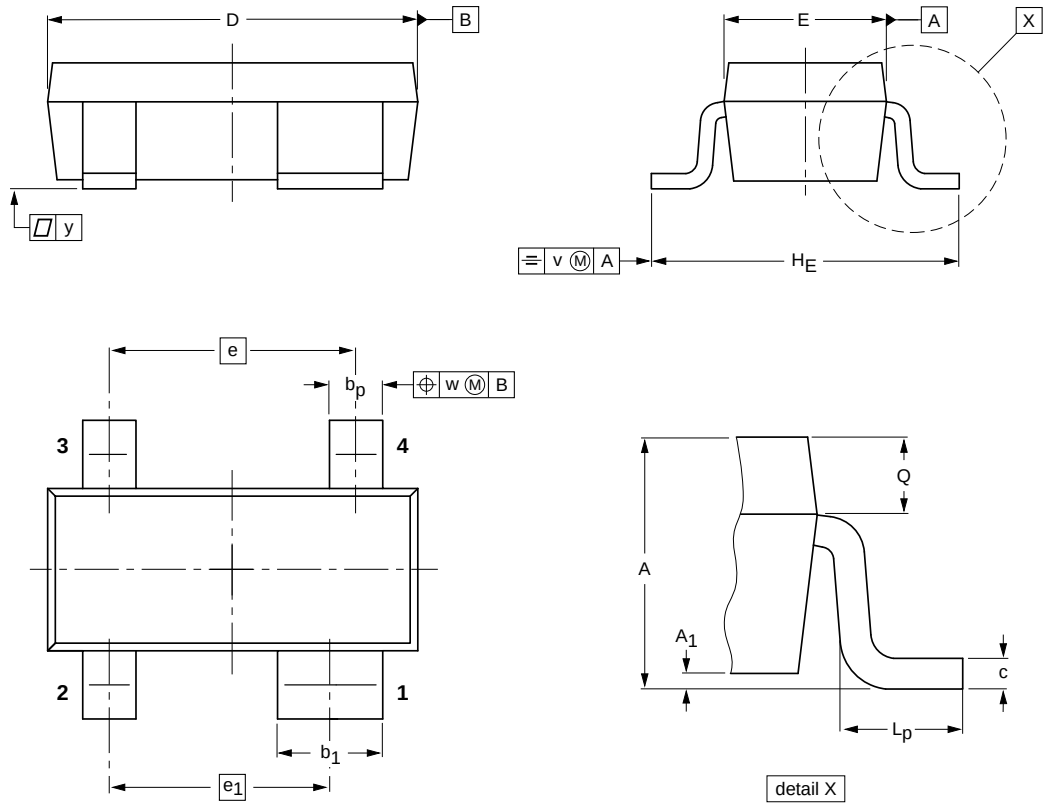


DIMENSIONS (mm are the original dimensions)

UNIT	A	A_1 max	b_p	b_1	c	D	E	e	e_1	H_E	L_p	Q	v	w	y
mm	1.1 0.9	0.1	0.48 0.38	0.88 0.78	0.15 0.09	3.0 2.8	1.4 1.2	1.9	1.7	2.5 2.1	0.45 0.15	0.55 0.45	0.2	0.1	0.1

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT143B						~~04-11-16~~ 06-03-16

Plastic surface-mounted package; reverse pinning; 4 leads **SOT143R**

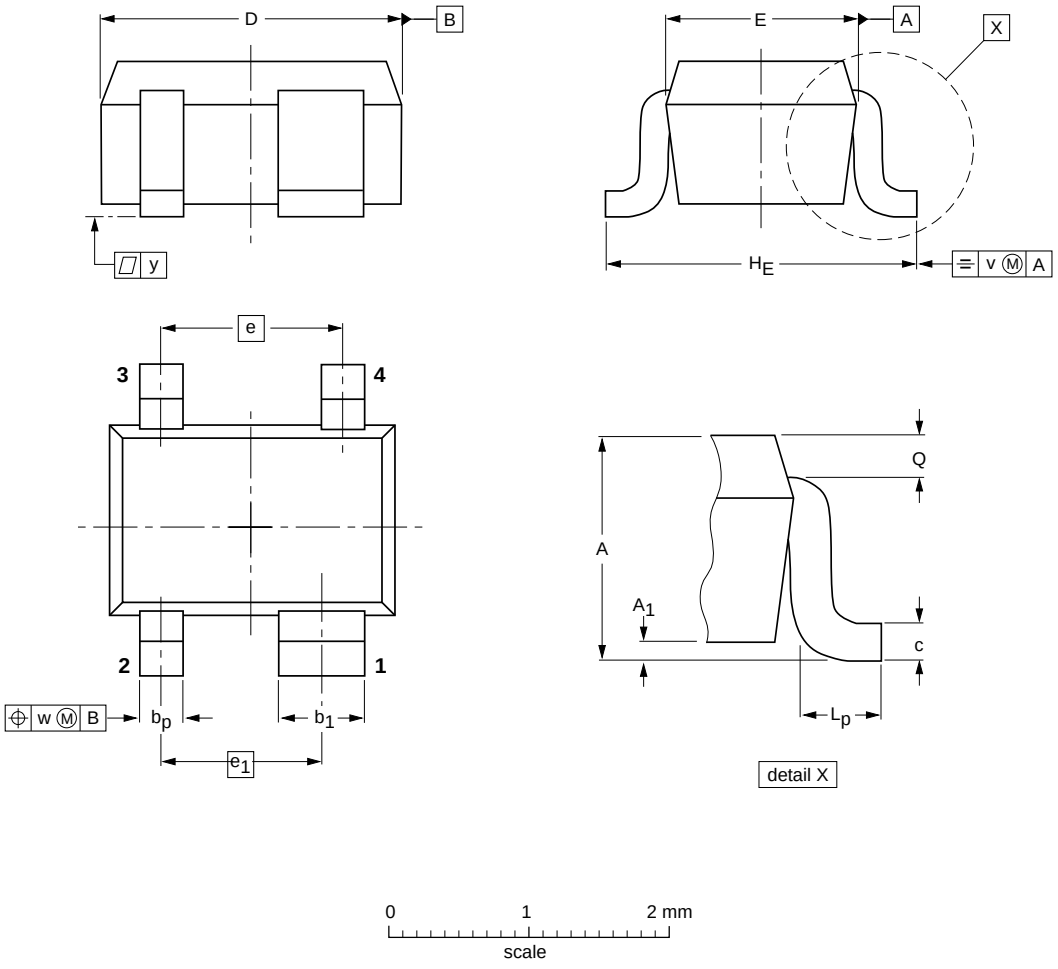


DIMENSIONS (mm are the original dimensions)

UNIT	A	A_1 max	b_p	b_1	c	D	E	e	e_1	H_E	L_p	Q	v	w	y
mm	1.1 0.9	0.1	0.48 0.38	0.88 0.78	0.15 0.09	3.0 2.8	1.4 1.2	1.9	1.7	2.5 2.1	0.55 0.25	0.45 0.25	0.2	0.1	0.1

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT143R			SC-61AA			~~04-11-16~~ 06-03-16

Plastic surface-mounted package; reverse pinning; 4 leads **SOT343R**



DIMENSIONS (mm are the original dimensions)

UNIT	A	A_1 max	b_p	b_1	c	D	E	e	e_1	H_E	L_p	Q	v	w	y
mm	1.1 0.8	0.1	0.4 0.3	0.7 0.5	0.25 0.10	2.2 1.8	1.35 1.15	1.3	1.15	2.2 2.0	0.45 0.15	0.23 0.13	0.2	0.2	0.1

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT343R						~~97-05-21~~ 06-03-16

DATA SHEET STATUS

DOCUMENT STATUS[1]	PRODUCT STATUS[2]	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

Notes

1. Please consult the most recently issued document before initiating or completing a design.
2. The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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This data sheet was changed to reflect the new company name NXP Semiconductors, including new legal definitions and disclaimers. No changes were made to the technical content, except for package outline drawings which were updated to the latest version.

Contact information

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